

Search Notes

Application/Control No.

10/748,053

Examiner

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Applicant(s)/Patent under
Reexamination

HAMASAKI ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
709	201	1/3/2008	DB
709	203	1/3/2008	DB
455	414	1/3/2008	db

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	1/3/2008	DB
Double Patenting search	1/3/2008	DB